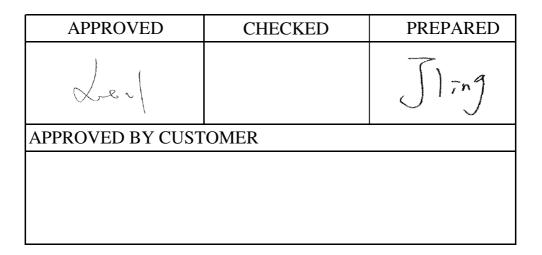
Confidential

# APPROVAL SHEET

Customer Name	:				
Customer P/N	:				
Frequency	:	12.288000	MHz		
Aker Approved P/N	:	SMAN-012288-3-D4-00			
Aker MPN		SMAN-012288-3-D4-00	)		
Rev.		1			
ISSUE DATE		Feb.10.2023			



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Web: www.aker.com.tw

MSL:Level 1 RoHS compliant



Aker Approved P/N	:	SMAN-012	SMAN-012288-3-D4-00			
APPROVED	:	Xtal	SHEET : 1 of 10			
PREPARED	:	JLING	REV. : 1			
			Confidential			

[	[		
Rev.	Date	Reviser	Revise contents
1	2023/2/10	JLING	Initial Released
L			



Aker Approved H	P/N :	SMAN-01	SMAN-012288-3-D4-00		
APPROVED	:	Xtal	SHEET : 2 of 10		
PREPARED	•	JLING	REV. : 1		
			Confidential		

## SMD CRYSTAL OSCILLATOR

#### **1. ELECTRICAL CHARACTERISTICS**

Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurement and tests are as follow :

Ambient temperature :  $25\pm5$  °C

Relative humidity : 40%~70%

If there is any doubt about the results, measurement shall be made within the following limits:

Ambient temperature : 25±3 °C

Relative humidity : 40%~70%

■ AKER Model : SMAN-321

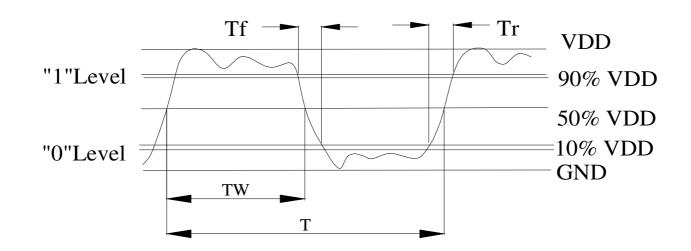
• Cutting Mode : AT CUT

			Electrical Spec					
Parameters	Symbol	Min.	Тур.	Max.	Units.	Notes		
Nominal Frequency		1	2.288000	0	MHz			
Frequency Stability			±50		ppm			
Supply Voltage	Vcc		3.3±10%	1	V			
Output Load CMOS	CL			15	pF			
Aging			±3		ppm	First Year		
Enable Control			Yes			Pad 1		
Operating Temperature		-40	25	85	°C			
Storage Temperature Range		-55	~	125	°C			
Output Voltage High	VoH	90%Vdd	90%Vdd		V			
Output Voltage Low	VoL			10%Vdd	V			
Input Current	Icc			7	mA			
Standby Current	Ist			10	μA			
Rise Time	Tr			5	ns	10%~90%VDD Level		
Fall Time	Tf			5	ns	90%~10%V <sub>DD</sub> Level		
Symmetry (Duty ratio)	TH/T	45	~	55	%			
Start-up Time	Tosc			10	ms			
Enable Voltage High	Vhi	70%Vdd			V			
Disable Voltage Low	Vlo			30%Vdd	V			
Output Enable Delay Time	T on			10	ms			
Output Disable Delay Time	T off			200	ns			
Phase Jitter RMS				1	ps	12KHz~5MHz		
*Please kindly be noted that AKER	DO NOT g	*Please kindly be noted that AKER DO NOT guarantee parts quality which involves human security application.*						

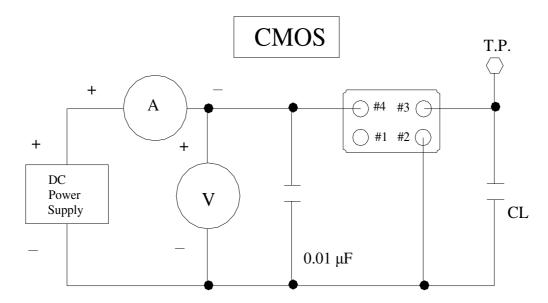


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## 2. C - MOS LOAD OUTPUT WAVEFORM



## **3.C-MOS LOAD TEST CIRCUIT**

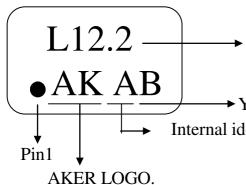


\*\*\*Because SMA series has no by pass capacitor. So,we recommend our customer to use capacitor  $0.01 \ \mu F$  in join Vcc and GND.



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4. MARKING :



Voltage Note1 & FREQUENCY

→ Year/Month Code : Please make refer to following tables. Internal identification code

NOTE1:	
Т	5.0V TTL
С	4.5~5.0V CMOS
L	2.97~3.63V TTL&CMOS
R	2.8~3.0V CMOS
S	2.25~2.75V СМО\$
Y	1.5~2.0V CMOS
Z	0.8~1.4V CMOS
W	Voltage Range CMOS

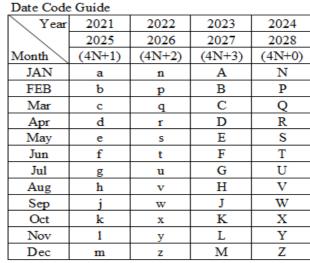
### **5. DIMENSION :**

#### Enable / Disable Function

E/D(#1)	OUTPUT(#3)
HIGH (Open)	Operating
LOW	High impedance

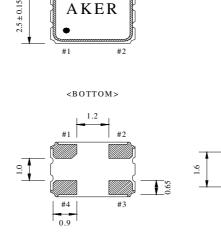
#### PIN FUNCTION

- #1 : Enable / Disable Control
- #2 : GND
- #3 : OUTPUT
- #4 : VDD



A cycle every four years

#### ( UNIT : mm )

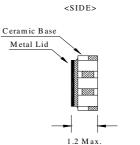


<T O P>

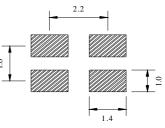
 $3.2 \pm 0.15$ 

#3

#4



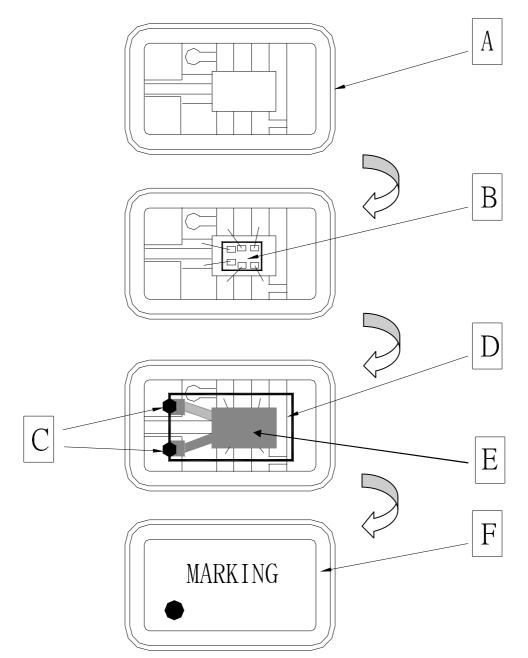
<SUGGESTED LAYOUT>





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## **6 . STRUCTURE ILLUSTRATION**



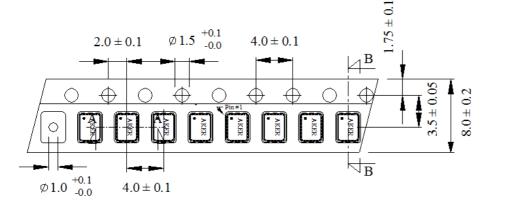
COMPONENTS		MATERIALS		MPONENTS	MATERIALS
A	Base (Package)	Ceramic (Al2O3)+Kovar (Fe/Co/Ni)	D	Crystal blank	SiO2
В	IC chip		E	Electrode	Cr / Ag
С	Conductive adhesive	Ag / Silicon resin	F	Lid	Fe/Co/Ni

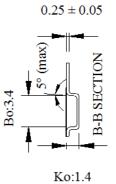


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## 7. PACKING :

#### TAPE SPECIFICATION





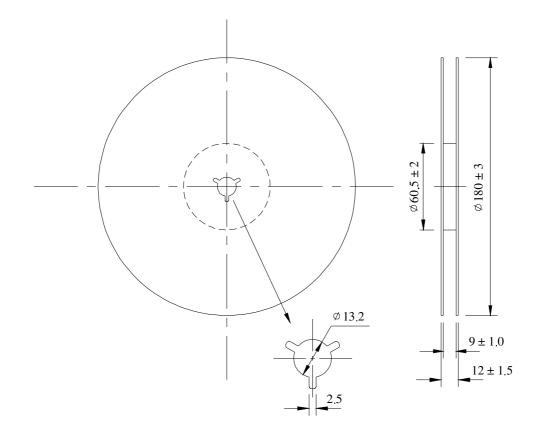
(Unit:mm)

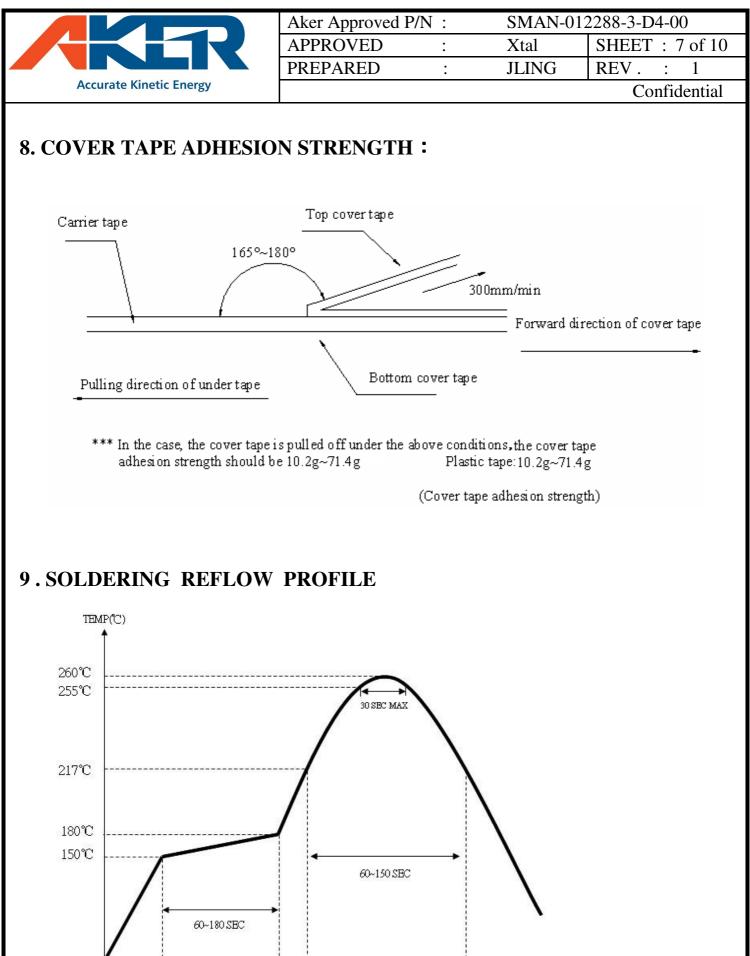
Ao:2.7 5° (max) A-A SECTION



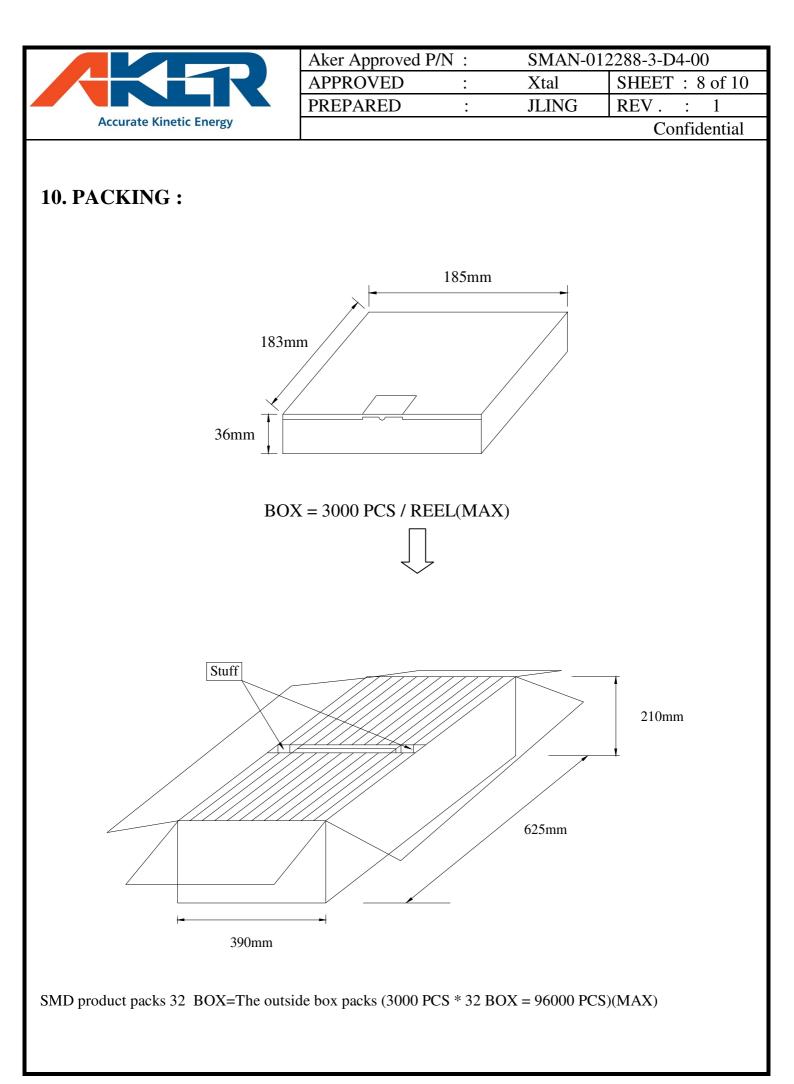
**OUTLINE DIMENSION** 

(Unit:mm)





TIME(SEC)





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## **11. MECHANICAL PERFORMANCE**

11. MECHANICAL PERFORMANCE					
TEST ITEMS	TEST METHODS AND TEST CONDITION	PERFORMANCE			
11.1 Drop Test	The specimen is measured for its frequency before the test. It is then dropped from a hight of 75 cm or more as a free fall object onto a hard wooden plate of 30mm or more in thickness. ( in accordance with JIS-C0044 )				
11.2 Vibration Test	The specimen is measured for its frequency before the test. Most them into X,Y and Z axes, respectively, for the vibration test. Vibration condition: Frequency range ; $20 \sim 2000$ HZ Peak to peak amplitude : 1.52 mm Peak acceleration : $20G$ Sweep time : $20$ minute / axis Pendicular total test time : 4 hours ( in accordance with MIL-STD-883F : $2007.3$ )	To satisfy the electrical performance .			
11.3 Resistance to Soldering Test	The specimen is measured for its frequency before the test. Place the specimen on the belt of the converynace and let it pass through the reflow with the presetted temperature condition. After passing twice the reflow place, the specimen under the referee condition for -~2 hours and then measure its electrical performance. Temperature Condition of IR Simulation: The temperature range of the preheated section is setted at $150 \sim 180^{\circ}$ C for $60 \sim 120$ sec. For the next section the temperature range is setted at $217 \sim 260^{\circ}$ C for $45 \sim 90$ sec. and within this time range the specimen should be able to sustain at the peak temperature, $260+/-3^{\circ}$ C , for 10 sec long. ( in accordance with JESD22-B106-B )				
11.4 Fine Leak Test	Place the specimen in a pressurized container and pressurize it with the detection gas (mixed gas consisting of 95% or more helium) for at least 2 hours. Complete the measurement of the concentration of helium within 30 min after taking it out from the pressurized container. ( in accordance with MIL-STD-883F : 1014.11 )	Less than 1.0 * 10 <sup>-8</sup> atm .c.c. / sec, Helium			
	The referee condition . Temperature $25 \pm 2$ °C Humidity $44 \sim 55$ % Pressure $86 \sim 106$ kPa ( in accordance with MIL-STD-883E : 1014.9 )				



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## **12. CLIMATIC RESISTANCE**

		I
TEST ITEMS	TEST METHODS AND TEST CONDITION	PERFORMANCE
12.1 Low Temp Exposure Test	The specimen is measured for its frequency before the test . Place the specimen in the chamber and kept it at the temperature of $-40 \pm 3^{\circ}$ C for $168 \pm 6$ hours . Take the specimen out of the chamber and measure itselectrical performance after leaving $1 \sim 2$ hours under the referee condition. ( in accordance with JIS-C0020 )	
12.2 Aging Test	The specimen is measured for its frequency before the test . Place the specimen in the testing chamber and keep it at the temperature of $+ 125 \pm 3^{\circ}$ C for 720 $\pm 48$ hours. And then take the specimen out of the chamber and measure its electrical performance after leaving for 1 $\sim$ 2 hours under the referee condition . ( in accordance with JIS-C0021 )	To satisfy the electrical performance .
12.3 High Temperature & High Humidty	The specimen is measured for its frequency before the test . Place the specimen in the testing chamber and kept it at the temperature of $+85 \pm 5$ °C and humidity of $85 \pm 5$ % for $168 \pm 6$ hours.and then take the specimen out and measure its electrical performance after leaving for $1 \sim 2$ hours under the referee condition. ( in accordance with MIL-STD-883F: 1004.7 )	
12.4 Temperature Cycle Test	The specimen is measured for its frequency before the test . Subject the specimen to the 100 cycles of temperature ranges stated below . High temp . + 125 ± 3 °C (15± 3 min). $2\sim 3 \text{ min}$ $2\sim 3 \text{ min}$ Low temp55 ± 3 °C (15± 3 min). Measure its electrical performance after leaving it for 1 ~ 2 hours under the referee condition . ( in accordance with MIL-STD-883F : 1010.8 )	